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IAP20 Rec'd PCT/PTO 20 APR 2006

PATENT
450100-05304

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Yutaka SATO et al.
International Application No.: PCT/JP2004/015197
International Filing Date: October 7, 2004
For: LIGHT AMOUNT CONTROL APPARATUS AND
CAMERA APPARATUS

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Sir:

Enclosed are copies of the publications, which were cited in the International
Search Report of International Application No. PCT/JP2004/015197. Also enclosed is a copy
of Form PTO-1449 and the International Search Report.

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REMARKS

Entry of this Information Disclosure Statement and an early examination on the
merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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Sheet 1 of 1

Based on Form PTO-1449 (3/90) LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-05304	SERIAL NO. 10/076,395 Filed Concurrently Herewith
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/Y.A./	AL	JP 2003-131189	05/08/03	Japan			
/Y.A./	AM	JP 6-54253	02/25/94	Japan			
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